

<b>Notice of References Cited</b>	Application/Control No. 10/729,225	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner TAN Q. NGUYEN	Art Unit 3661	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,374,177	04-2002	Lee et al.	701/200
*	B	US-6,421,602	07-2002	Bullock et al.	701/201
*	C	US-6,691,028	02-2004	Bullock et al.	701/202
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
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**NON-PATENT DOCUMENTS**

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